

## **Excellent Integrated System Limited**

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Maxim Integrated MAX9672ETI+

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Datasheet of MAX9672ETI+ - IC GAMMA REF SYST 10BIT 28TQFN Contact us: sales@integrated-circuit.com Website: www.integrated-circuit.com



MAX9672

RELIABILITY REPORT

FOR MAX9672ETI+

PLASTIC ENCAPSULATED DEVICES

October 30, 2009

#### **MAXIM INTEGRATED PRODUCTS**

120 SAN GABRIEL DR. SUNNYVALE, CA 94086

Approved by	
Richard Aburano	
Quality Assurance	
Manager, Reliability Operations	



# Distributor of Maxim Integrated: Excellent Integrated System Limited Datasheet of MAX9672ETI+ - IC GAMMA REF SYST 10BIT 28TQFN

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#### Conclusion

The MAX9672ETI+ successfully meets the quality and reliability standards required of all Maxim products. In addition, Maxim's continuous reliability monitoring program ensures that all outgoing product will continue to meet Maxim's quality and reliability standards.

#### **Table of Contents**

IDevice Description	VQuality Assurance Information
IIManufacturing Information	VIReliability Evaluation
IIIPackaging Information	IVDie Information
Attachments	

#### I. Device Description

A. General

The MAX9672/MAX9674 output 12/14/16 voltage references for gamma correction in TFT LCDs and one voltage reference for VCOM. Each gamma reference voltage has its own 10-bit DAC and buffer to ensure a stable voltage. The VCOM reference voltage has its own 10-bit DAC and an amplifier to ensure a stable voltage when critical levels and patterns are displayed. The MAX9672/MAX9673/MAX9674 feature integrated multiple-time programmable (MTP) memory to store gamma and VCOM values on the chip, eliminating the need for external EEPROM. The MAX9672/MAX9673/MAX9674 support up to 100 write operations to the on-chip nonvolatile memory. The gamma outputs can drive 200mA peak transient current and settle within 1µs. The VCOM output can provide 600mA peak transient current and also settles within 1µs. The analog supply voltage range extends from 9V to 20V, and the digital supply voltage range extends from 2.7V to 3.6V. Gamma values and the VCOM value are programmed into registers through the I²C interface.



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#### II. Manufacturing Information

A. Description/Function: 10-Bit, Programmable Gamma Reference Systems with MTP for TFT LCDs

B. Process: S45C. Number of Device Transistors: 4548

D. Fabrication Location: California, Texas or Japan

E. Assembly Location: ThailandF. Date of Initial Production: July 25, 2009

#### III. Packaging Information

A. Package Type: 28-pin TQFN 5x5

B. Lead Frame: Copper

C. Lead Finish: 100% matte Tin
D. Die Attach: Conductive
E. Bondwire: Au (1 mil dia.)
F. Mold Material: Epoxy with silica filler
G. Assembly Diagram: #05-9000-3808
H. Flammability Rating: Class UL94-V0

I. Classification of Moisture Sensitivity per

JEDEC standard J-STD-020-C

J. Single Layer Theta Ja: 47°C/W
K. Single Layer Theta Jc: 1.7°C/W
L. Multi Layer Theta Ja: 29°C/W
M. Multi Layer Theta Jc: 1.7°C/W

#### IV. Die Information

A. Dimensions: 99 X 101 mils

B. Passivation: Si<sub>3</sub>N<sub>4</sub>/SiO<sub>2</sub> (Silicon nitride/ Silicon dioxide)

C. Interconnect: Al/0.5%Cu with Ti/TiN Barrier

D. Backside Metallization: None

E. Minimum Metal Width: Metal1 = 0.5 / Metal2 = 0.6 / Metal3 = 0.6 microns (as drawn)
 F. Minimum Metal Spacing: Metal1 = 0.45 / Metal2 = 0.5 / Metal3 = 0.6 microns (as drawn)

Level 1

G. Bondpad Dimensions: 5 mil. Sq.
 H. Isolation Dielectric: SiO<sub>2</sub>
 I. Die Separation Method: Wafer Saw



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MAX9672

#### V. Quality Assurance Information

A. Quality Assurance Contacts: Ken Wendel (Director, Reliability Engineering)

Bryan Preeshl (Managing Director of QA)

B. Outgoing Inspection Level: 0.1% for all electrical parameters guaranteed by the Datasheet.

0.1% For all Visual Defects.

C. Observed Outgoing Defect Rate: < 50 ppm</li>D. Sampling Plan: Mil-Std-105D

#### VI. Reliability Evaluation

A. Accelerated Life Test

The results of the 135°C biased (static) life test are shown in Table 1. Using these results, the Failure Rate ( 3) is calculated as follows:

$$\lambda = \underbrace{\frac{1}{\text{MTTF}}}_{\text{emperature}} = \underbrace{\frac{1.83}{192 \times 4340 \times 48 \times 2}}_{\text{(where 4340 = Temperature Acceleration factor assuming an activation energy of 0.8eV)}}_{\lambda = 22.9 \times 10^{-9}}$$

$$\lambda = 22.9 \text{ F.I.T. (60\% confidence level @ 25°C)}$$

The following failure rate represents data collected from Maxim"s reliability monitor program. Maxim performs quarterly life test monitors on its processes. This data is published in the Reliability Report found at http://www.maxim-ic.com/qa/reliability/monitor.

Cumulative monitor data for the S45 Process results in a FIT Rate of 0.49 @ 25C and 8.49 @ 55C (0.8 eV, 60% UCL)

B. Moisture Resistance Tests

The industry standard 85°C/85%RH or HAST testing is monitored per device process once a quarter.

C. E.S.D. and Latch-Up Testing

The DV26 die type has been found to have all pins able to withstand a transient pulse of:

HBM: +/-2500V per JEDEC JESD22-A114 CDM: +/-750V per JEDEC JESD22-C101 MM: +/-250V per JEDEC JESD22-A115

Latch-Up testing has shown that this device withstands a current of +/- 250mA and Vcc Overvoltage per JESD78.



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MAX9672

## Table 1 Reliability Evaluation Test Results

#### MAX9672ETI+

TEST ITEM	TEST CONDITION	FAILURE IDENTIFICATION	SAMPLE SIZE	NUMBER OF FAILURES	
Static Life Test	(Note 1)				
	Ta = 135°C Biased	DC Parameters & functionality	48	0	
	Time = 192 hrs.	a ranonomanty			
Moisture Testing	(Note 2)				
HAST	Ta = 130°C	DC Parameters	77	0	
	RH = 85%	& functionality			
	Biased Time = 96hrs.				
Mechanical Stres	ss (Note 2)				
Temperature	-65°C/150°C	DC Parameters	77	0	
Cycle	1000 Cycles	& functionality			
	Method 1010				

Note 1: Life Test Data may represent plastic DIP qualification lots.

Note 2: Generic Package/Process data